

# RMPA61810

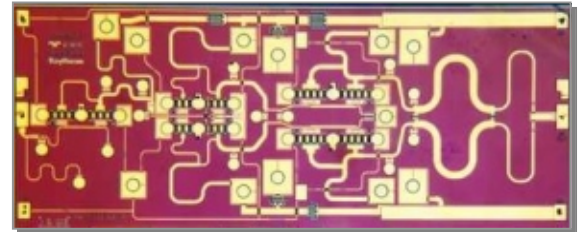
## Single Channel 6-18 GHz 1 Watt Power Amplifier MMIC

**Description**

The Raytheon RMPA61810 is a fully monolithic power amplifier operating over the 6.0 to 18.0 GHz frequency band. The amplifier uses a 0.25 micron Pseudomorphic High Electron Mobility Transistor (PHEMT) process to maximize efficiency and output power. The chip configuration incorporates two stages of reactively combined amplifiers at the output preceded by an input amplifier stage. This single channel amplifier provides typically, 21 dB small signal gain and 31 dBm output power at 1 dB gain compression.

**Features**

- ◆ 21 dB Typical Small Signal Gain
- ◆ 2.0:1 Typical Input VSWR, 2.5:1 Typical Output VSWR
- ◆ 31 dBm Output Power at 1 dB Gain Compression
- ◆ 32 dBm Output Power at 3 dB Gain Compression
- ◆ 22% Typical Power Added Efficiency at 1 dB Gain Compression
- ◆ Chip size: 6.55 mm x 2.67 mm x 0.1 mm



**Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Positive Drain DC Voltage	Vd	8.5	V
Negative DC Voltage	Vg	-2	V
Simultaneous (Vd-Vg)	Vdg	+10.5	V
RF CW Input Power (50 Ω source)	Pin	27	dBm
Drain Current	Id	1.2	A
Storage Temperature	Tstg	-55 to +125	°C
Operating Base Plate Temp	Tc	-40 to +85	°C
Thermal Resistance (Channel to Backside)	Rjc	12	°C/W

**Performance Characteristics**

(at 25°C)  
50 Ω system,  
Vd=+8V, Quiescent  
Current (Idq=600 mA)

Parameter	Min	Typ	Max	Unit
Frequency Range	6.0		18.0	GHz
Small Signal Gain	15	21		dB
P1dB Compression	28	31		dBm
P3dB Compression	30	32		dBm
PAE at 1 dB Gain Comp.	12	22		%

Parameter	Min	Typ	Max	Unit
Input Return Loss		9.5		dB
Output Return Loss		7.4		dB
Gate Voltage (Vg) <sup>1</sup>		-0.4		V
Gain vs. Temp. 0~85°C		-0.025		dB/°C

**Note:**

1. Typical range at the negative gate voltage is -1 to 0V to set a typical Idq of 600 mA

**Characteristic performance data and specifications are subject to change without notice.**

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PRODUCT INFORMATION

### Application Information

**CAUTION: THIS IS AN ESD SENSITIVE DEVICE**

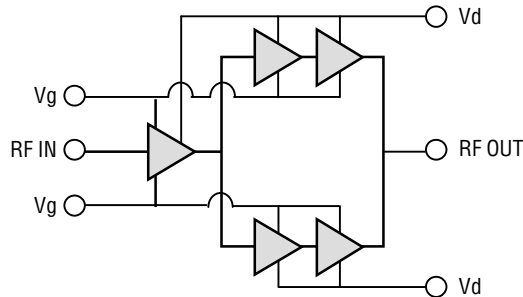
Chip carrier material should be selected to have GaAs compatible thermal coefficient of expansion and high thermal conductivity such as copper molybdenum or copper tungsten. The chip carrier should be machined, finished flat, plated with gold over nickel and should be capable of withstanding 325°C for 15 minutes.

Die attachment for power devices should utilize Gold/Tin (80/20) eutectic alloy solder and should avoid hydrogen environment for PHEMT devices. Note that the backside of the chip is gold plated and is used as RF and DC Ground.

These GaAs devices should be handled with care and stored in dry nitrogen environment to prevent contamination of bonding surfaces. These are ESD sensitive devices and should be handled with appropriate precaution including the use of wrist-grounding straps. All die attach and wire/ribbon bond equipment must be well grounded to prevent static discharges through the device.

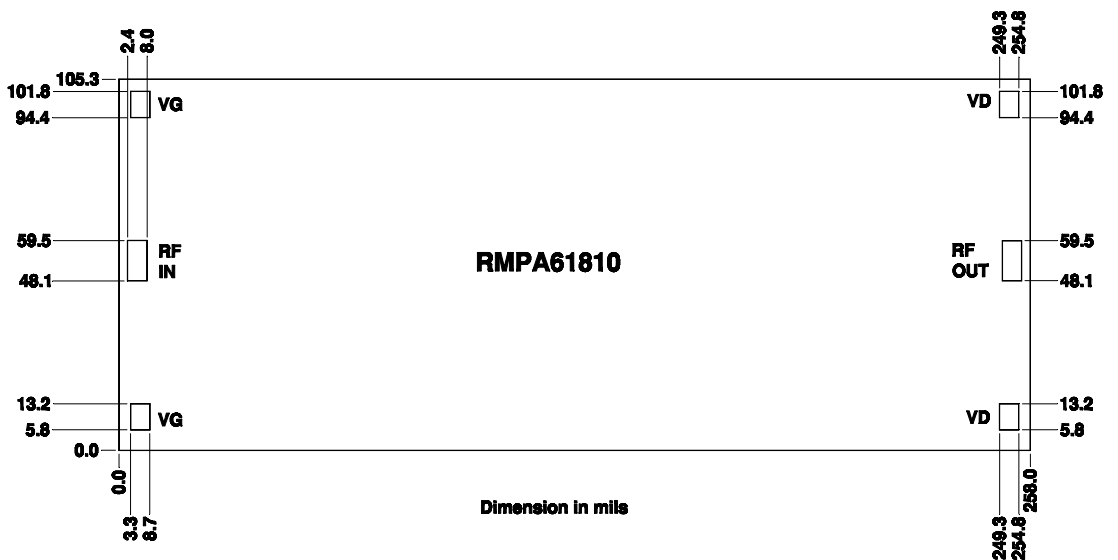
Recommended wire bonding uses 3 mils wide and 0.5 mil thick gold ribbon with lengths as short as practical allowing for appropriate stress relief. The RF input and output bonds should be typically 0.012" long corresponding to a typical 2 mil gap between the chip and the substrate material.

**Figure 1**  
Functional Block Diagram



**Figure 2**  
Chip Layout and Bond Pad Locations

(Chip size=6.55mm x 2.67mm x 100µm.  
Back of Chip is RF and DC Ground)



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**Application Note****Scope:**

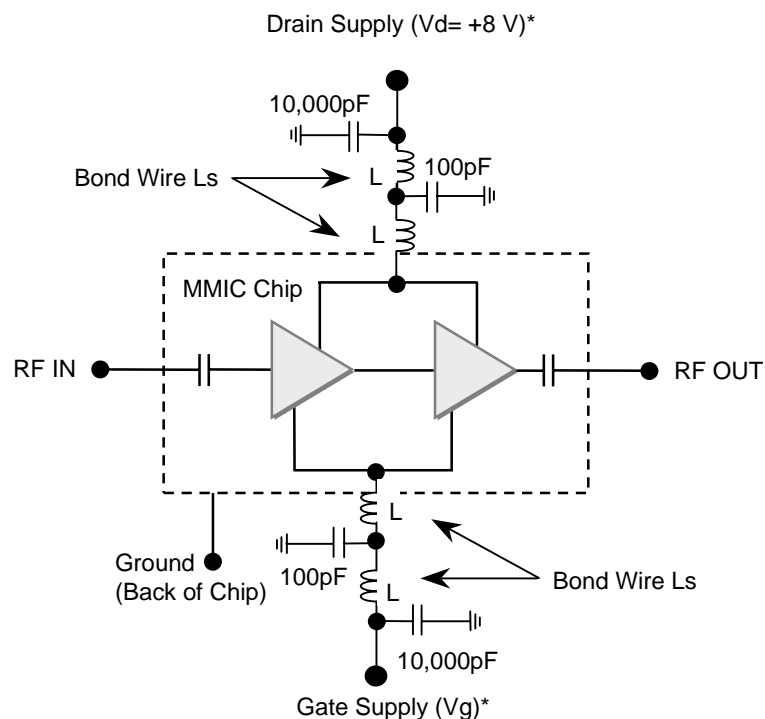
This application note briefly describes the procedure for evaluating the Raytheon RMPA61810, high efficiency 0.25  $\mu\text{m}$  PHEMT Single-Channel Amplifier. The chip configuration incorporates two stages of reactively combined amplifiers at the output preceded by an input amplifier stage.

**Carrier Assembly:**

The attached drawing shows a recommended off chip bias scheme for the RMPA61810. The MMIC is mounted on a Cu shim or ridge, which in turn is blazed to Cu-Mo-Cu, or Cu-W, or Mo carrier with alumina 50-ohm microstrip lines for in/out RF connections and off-chip DC bias components. The drawing shows the placement of components and bond wire connections. The following should be noted:

- (1) 1 mil gold bond wires are used on the carrier assembly.
- (2) Use 3-1 mil gold wires about 25 mils in length for optimum RF performance.
- (3) Vg: Gate Voltage (negative) input terminal for amplifier stages. For best results, the gate supply should have a source resistance less than 100 ohms.
- (4) Vd: Drain Voltage (positive) input terminal for amplifier stages.
- (5) Vg and Vd on both sides of the MMIC must be biased to insure proper operation.
- (6) Bias decoupling capacitors of 0.01  $\mu\text{F}$  (multilayer) and 100 pF (single layer) are used on the carrier.
- (7) Close placement of external components is essential to stability.
- (8) The test fixture may require a pair of 25  $\mu\text{F}$  capacitor on the drain and gate(optional) bias terminals to prevent oscillations caused by the test fixture connections.
- (9) For Laboratory testing, use good power supplies. Set current limits on supplies to RF drive-up current level. Keep supply wire/leads as short as possible and if required use additional bypass capacitors at the fixture terminals.

**Figure 3**  
Recommended  
Application Schematic  
Circuit Diagram



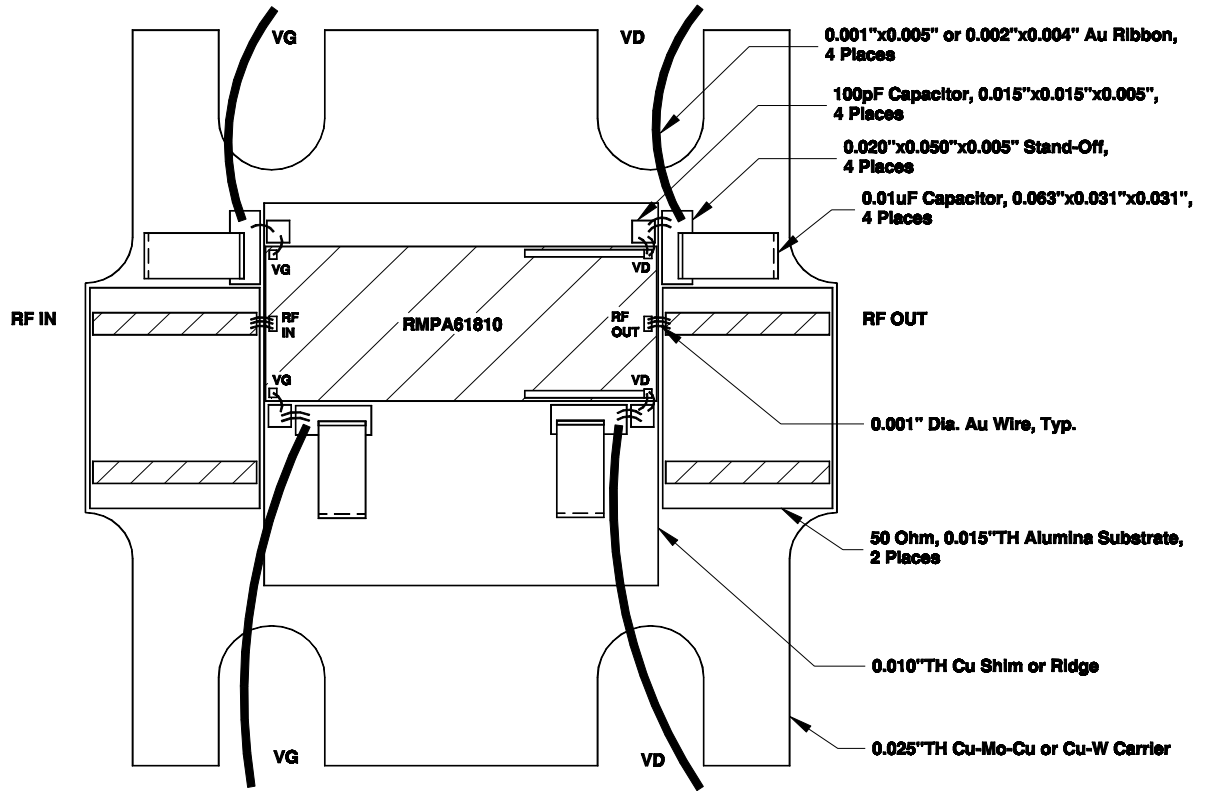
\*Vg and Vd on both sides of the MMIC must be biased to insure proper operation.

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**Figure 4**  
Recommended  
Assembly and  
Bonding Diagram



**Recommended Procedure**  
for biasing and operation

**CAUTION: LOSS OF GATE VOLTAGE (Vg) WHILE DRAIN VOLTAGE (Vd) IS PRESENT MAY DAMAGE THE AMPLIFIER. THIS AMPLIFIER IS AN ESD SENSITIVE DEVICE.**

The following procedure must be followed to properly test the amplifier:

**Step 1:** Slowly apply Gate Voltage (typical Vpinch-off= -1.5V) to terminal Vg.

**Step 2:** Slowly apply Drain Voltage at Vd (<+5 volts) and monitor drain current Ids. Adjust negative voltage Vg to set the drain current (Ids) to approximately 600 mA. Adjust the drain voltage Vg to nominal +8 volts (adjust Gate Voltage Vg, if needed, to maintain the drain current at Ids).

**Step 3:** After the bias condition is established, RF input signal may now be applied at the appropriate frequency band.

**Step 4:** Follow Turn-off sequence:

- (i) RF input power=off,
- (ii) Vd=off,
- (iii) Vg=off.

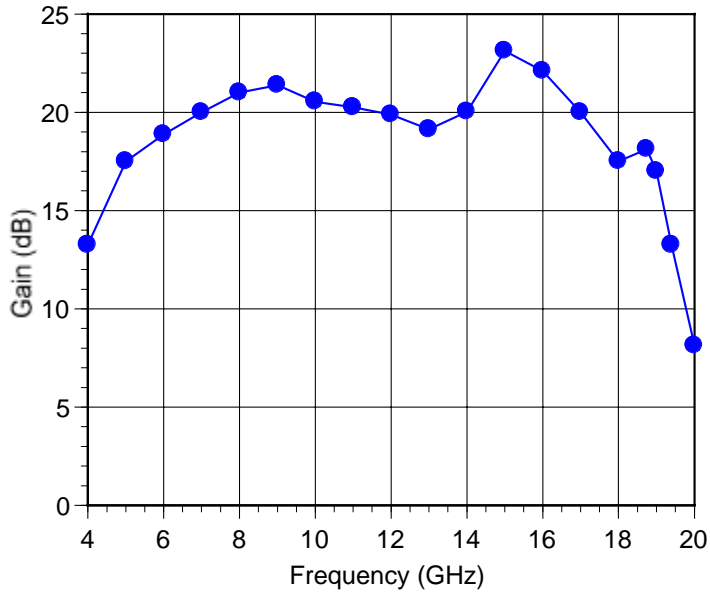
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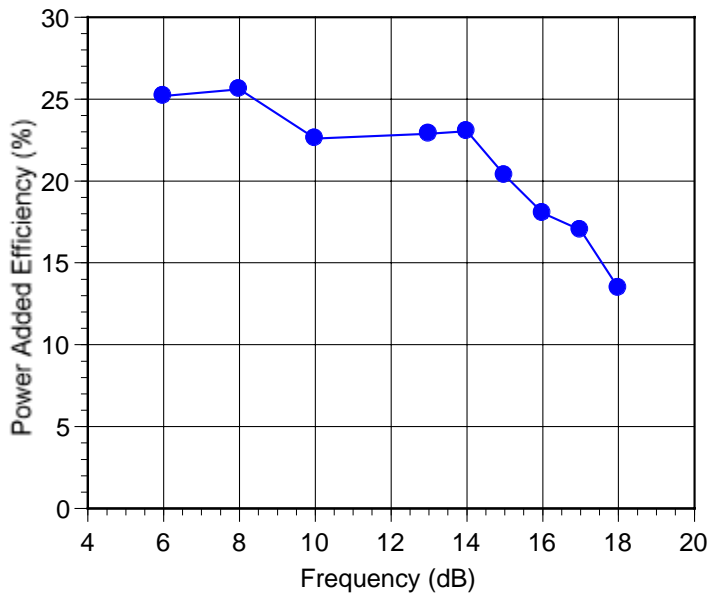
## Single Channel 6-18 GHz 1 Watt Power Amplifier MMIC

Typical Characteristics

**Small Signal Gain**  
 $V_d=8.0V, I_{dQ}=600mA$



**Power Added Efficiency @ P1**  
 $V_d=8.0V, I_{dQ}=600 mA$



The above data is derived from fixtured measurements which includes 3 parallel, 1 mil diameter, 15 mil long, gold bond wires connected to the RF input and output.

The  $I_d$  @ 1 dB compression increases to 1 A or thereabouts. The dc supply should be able to support the required current to achieve the above performance.

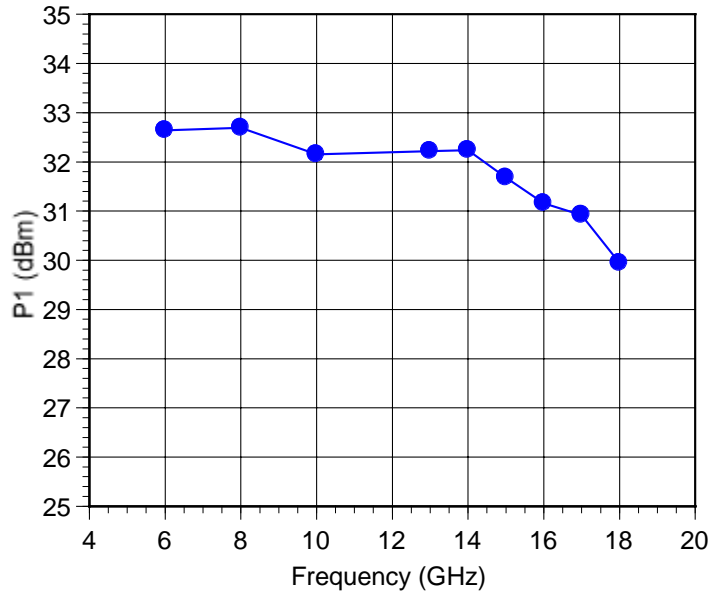
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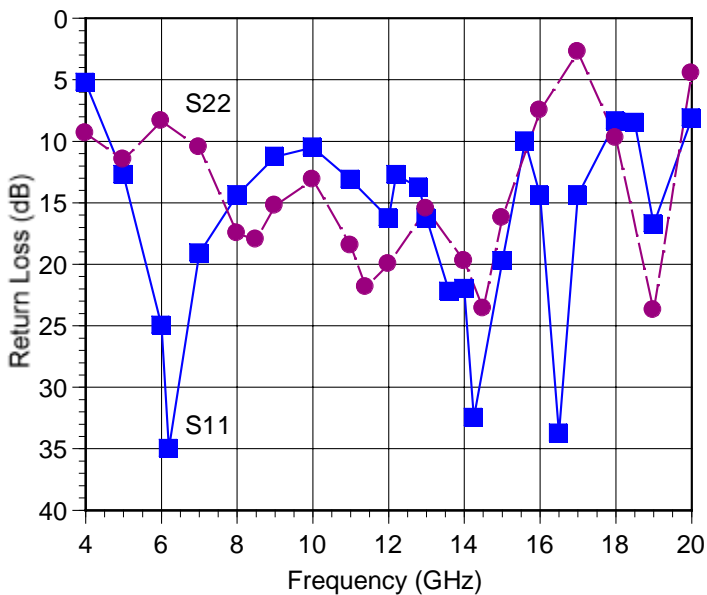
## Single Channel 6-18 GHz 1 Watt Power Amplifier MMIC

Typical Characteristics

**Output Power @ 1 dB Compression**  
 $V_d=8.0V, I_{dq}=600mA$



**Input & Output Return Loss**  
 $V_d=8.0V, I_{dq}= 600mA$



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